# ΗΙΟΚΙ

## LCR Meters for every purpose

High-Speed and High-Precision Measurements of Resistance, Capacitance and Inductance





LCR METER IM3533 / IM3533-01

General-purpose LCR meter up to 8MHz

Capable of special measurements of transformers including turn ratio and mutual inductance



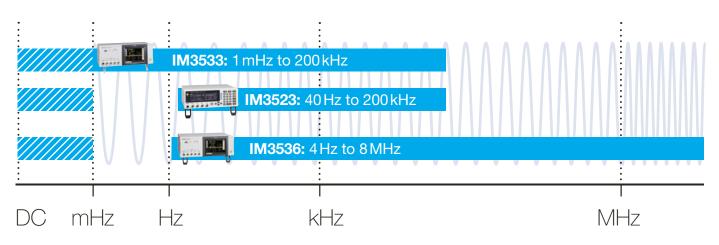
LCR METER IM3523 / IM3523A\*

Extremely cost-effective model suitable for production lines including integration into automated machinery

	IM3536	IM3533 / IM3533-01	IM3523 / IM3523A*
Measurement frequency	DC, 4Hz to 8MHz	DC, 1 mHz to 200 kHz	DC, 40 Hz to 200 kHz
Basic impedance accuracy (Z)	0.05%	0.05%	0.05%
Impedance measurement ranges (Z)	$100\text{m}\Omega$ to $100\text{M}\Omega,10$ ranges	$100\text{m}\Omega$ to $100\text{M}\Omega,10$ ranges	$100\text{m}\Omega$ to $100\text{M}\Omega,10$ ranges
Smallest resolution	1 mΩ	10 mΩ	10 mΩ
Frequency sweep testing	-	with IM3533-01	-
Measurement parameters	Z, Y, θ, X, G, B, Q, Rdc (DC resistance), Rs (ESR), Rp, Ls, Lp, Cs, Cp, D (tanδ), σ, ε	Z, Y, θ, X, G, B, Q, Rdc (DC resistance), Rs (ESR), Rp, Ls, Lp, Cs, Cp, D (tanδ), N, M, ΔL, T	Z, Y, θ, X, G, B, Q, Rdc (DC resistance), Rs (ESR), Rp, Ls, Lp, Cs, Cp, D (tanδ)

\*LAN standard model

#### LCR Meters for measurements from 1 mHz to 8 MHz



Do you need more information? Get in touch with us: hioki@hioki.eu I +49 6196 76515-0 I www.hioki.eu

### LCR Probes and Test Fixtures



CLIP TYPE PROBE L2000 DC to 8 MHz, measurable conductor diameter: Ø 0.3 to 5 mm, cable length 1 m



CLIP TYPE PROBE 9140-10 DC to 200kHz, measurable conductor diameter: Ø 0.3 mm to 5 mm, cable length 1 m

**TEST FIXTURE 9261-10** DC to 8MHz, measurable conductor diameter: Ø 0.3 to 1,5mm, cable length 1 m



PINCHER PROBE L2001 DC to 8MHz, measurable sampe sizes: 0603 to 2220 (EIA), 1608 to 5750 (JIS) with IM9901, 0201 to 2220 (EIA) 0603 to 5750 (JIS) with IM9902



TEST FIXTURE 9262 DC to 8 MHz, measurable conductor diameter: Ø 0.3 to 2 mm



SMD TEST FIXTURE 9263 Electrodes on the side, DC to 8MHz, measurable sample sizes: 0805 to 2220 (EIA), 2012 to 5750 (JIS)



SMD TEST FIXTURE IM9110 DC to 1 MHz, measurable sample sizes: 008004 (EIA), 0201 (JIS)



SMD TEST FIXTURE IM9100 DC to 8MHz, measurable sample sizes: 01005 to 0402 (EIA), 0402 to 1005 (JIS)



SMD TEST FIXTURE 9699 Electrodes on the bottom; DC to 120 MHz, measurable sample sizes: 0608 to 0805 (EIA), 1608 to 2012 (JIS)

#### SMD TEST FIXTURE 9677 Electrodes on the side;

DC to 120 MHz, measurable sample sizes: 0402 to 0603 (EIA), 1005 to 1608 (JIS)

#### **DC BIAS VOLTAGE UNIT 9268-10\*** 40 Hz to 8 MHz, maximum applied voltage of DC ±4 0V\*



40 Hz to 2 MHz, maximum applied current of DC 2 A\*

\*When using the 9268-10 or 9269-10, external constant-voltage and constant-current sources are required.

## Also discover our Impedance Analyzers



#### IMPEDANCE ANALYZER IM3570

The single device solution for high-speed testing and frequency sweeping from 4 Hz to 5 MHz, equivalent circuit analysis option available (IM9000)



**CHEMICAL IMPEDANCE ANALYZER IM3590** Single source range DC, 1 mHz to 200 kHz for R&D applications of electrochemical applications, batteries and EDLCs

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